Search Notes				

Application/Control No.		Applicant(s)/Pa Reexamination	Applicant(s)/Patent under Reexamination	
10/613,53	0	HOFFJANN ET	ΓAL.	
Examiner		Art Unit		
Matthew C). Savage			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

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Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/613,530	HOFFJANN ET AL.
Examiner	Art Unit

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210	748, 758, 806		
4	222		
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4	227.1		
4	665		
205	751	4/29/2005	MS
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